



DMT10H025SK3

Product Summary

BV _{DSS}	R _{DS(ON)} Max I _D M T _C = +2	
100V	23mΩ @ V _{GS} = 10V	41.2A
	30mΩ @ V _{GS} = 6V	36.1A

Description

This new generation MOSFET features low on-resistance and fast switching, making it ideal for high efficiency power management applications.

Applications

- **Power Management Functions**
- **DC-DC Converters**
- Backlighting

100V N-CHANNEL ENHANCEMENT MODE MOSFET

Features

- 100% Unclamped Inductive Switching Ensures More Reliable and Robust End Application
- Low R_{DS(ON)} Minimizes Power Losses
- Low Q_G Minimizes Switching Losses
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: TO252 (DPAK) •
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.33 grams (Approximate)

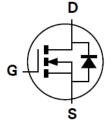




Top View



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Equivalent Circuit

Ordering Information (Note 4)

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Part Number	Case	Packaging
DMT10H025SK3-13	TO252 (DPAK)	2,500/Tape & Reel

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Pin Out Top View

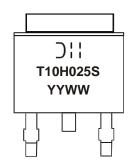
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1. EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant. All applicable RoHS exemptions applied. Notes: 2. See http://www.diodes.com/quality/lead_free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



DH = Manufacturer's Marking T10H025S = Product Type Marking Code YYWW = Date Code Marking YY = Last Two Digits of Year (ex: 18 = 2018) WW = Week Code (01 to 53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic		Symbol	Value	Unit
Drain-Source Voltage		V _{DSS}	100	V
Gate-Source Voltage		V _{GSS}	±20	V
Continuous Drain Current, $V_{GS} = 10V$ $T_C = +25^{\circ}C$ $T_C = +70^{\circ}C$		Ι _D	41.2 32.9	А
Pulsed Drain Current (10µs Pulse, T _C =+25°C, Package Limited)		I _{DM}	160	А
Maximum Continuous Body Diode Forward Current (Note 6)		Is	45	A
Pulsed Body Diode Forward Current (10µs Pulse, T _C =+25°C, Package Limited)		Ism	160	A
Avalanche Current, L = 0.1mH (Note 8)		I _{AS}	7.5	А
Avalanche Energy, L = 0.1mH (Note 8)		E _{AS}	2.8	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Total Power Dissipation (Note 5)		PD	1.4	W	
Thermal Resistance, Junction to Ambient (Note 5)	Steady State	R _{0JA}	81	°C/W	
Total Power Dissipation (Note 6)		PD	2.5	W	
hermal Resistance, Junction to Ambient (Note 6) Steady State		R _{0JA}	46	°C/W	
Thermal Resistance, Junction to Case		R _{0JC}	2.1	°C/vv	
Operating and Storage Temperature Range		TJ, TSTG	-55 to +150	°C	

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Turn	Мах	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)	Symbol	IVIIII	Тур	WidX	Unit	Test condition	
Drain-Source Breakdown Voltage	D)/	100		_	V	V 0V 1 1mA	
9	BV _{DSS}					$V_{GS} = 0V, I_D = 1mA$	
Zero Gate Voltage Drain Current	I _{DSS}			1	μA	$V_{DS} = 80V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}			±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)			1	1		1	
Gate Threshold Voltage	V _{GS(TH)}	2		4	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$	
Static Drain-Source On-Resistance	Proven	_	17.8	23	mΩ	$V_{GS} = 10V, I_D = 20A$	
	R _{DS(ON)}		22.9	30	11152	$V_{GS} = 6V, I_D = 20A$	
Diode Forward Voltage	V _{SD}	—	0.9	1.3	V	$V_{GS} = 0V, I_{S} = 20A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	Ciss		1544			$V_{DS} = 50V, V_{GS} = 0V$ f = 1MHz	
Output Capacitance	C _{oss}	—	250	_	pF		
Reverse Transfer Capacitance	C _{rss}	—	20.4	_			
Gate Resistance	Rg	_	1.26	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$	
Total Gate Charge (V _{GS} = 10V)	Qg	_	21.4				
Total Gate Charge (V _{GS} = 6V)	Qg	—	13.4	_	nC	$V_{DD} = 50V, I_D = 20A$	
Gate-Source Charge	Q _{gs}	_	4.6	_	nc		
Gate-Drain Charge	Q _{gd}	_	6.0	_			
Turn-On Delay Time	t _{D(ON)}	—	8.2	_			
Turn-On Rise Time	t _R		11.2			$V_{DD} = 50V, V_{GS} = 10V,$	
Turn-Off Delay Time	t _{D(OFF)}	_	27.5		ns	$I_{D} = 20A, R_{g} = 11\Omega$	
Turn-Off Fall Time	t _F	_	13.7			-	
Reverse Recovery Time	t _{RR}	_	37.5		ns		
Reverse Recovery Charge	Q _{RR}	_	50.9		nC	$I_F = 20A$, di/dt = 100A/µs	

Notes: 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.

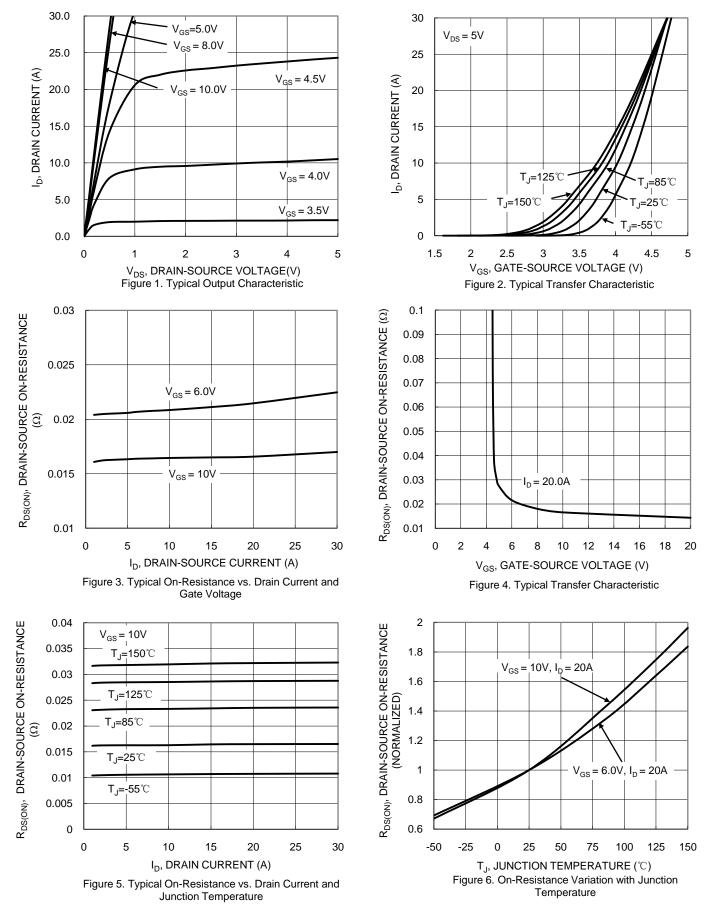
6. Thermal resistance from junction to soldering point (on the exposed drain pad).

7. Short duration pulse test used to minimize self-heating effect.

8. Guaranteed by design. Not subject to product testing.

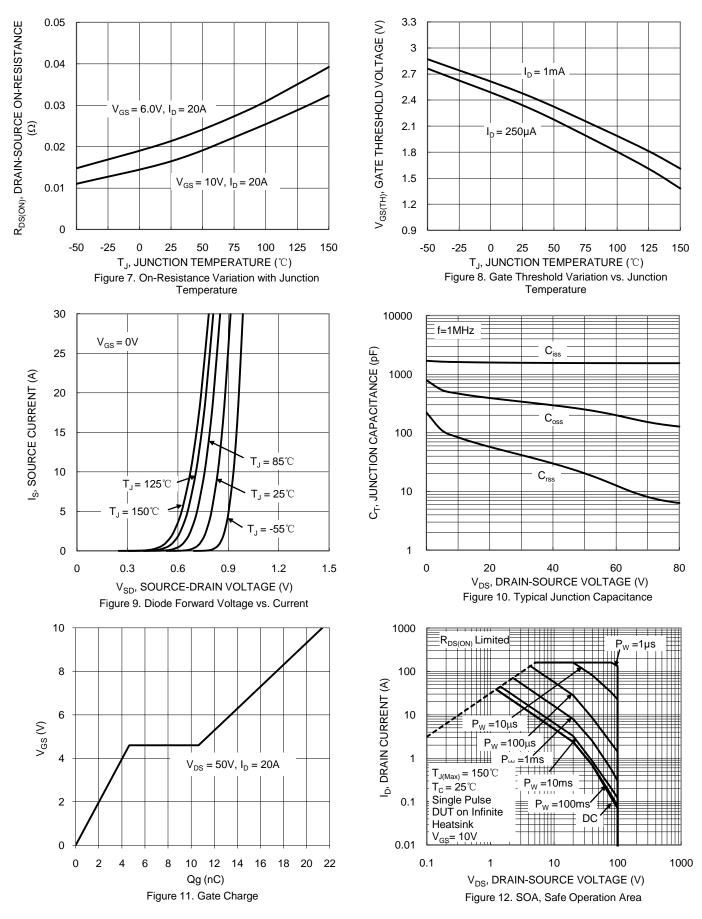


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DMT10H025SK3 Document number: DS40266 Rev. 4 - 2



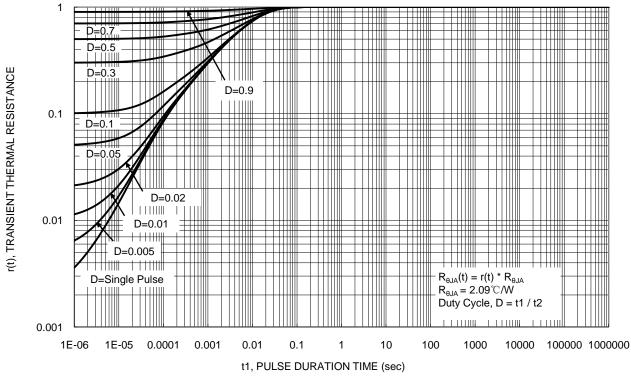


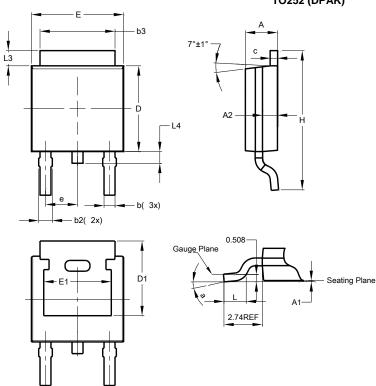
Figure 13. Transient Thermal Resistance



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Package Outline Dimensions

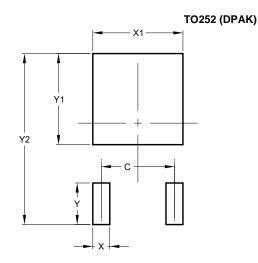
Please see http://www.diodes.com/package-outlines.html for the latest version.



TO252 (DPAK)					
Dim	Min	Max	Тур		
Α	2.19	2.39	2.29		
A1	0.00	0.13	0.08		
A2	0.97	1.17	1.07		
b	0.64	0.88	0.783		
b2	0.76	1.14	0.95		
b3	5.21	5.46	5.33		
С	0.45	0.58	0.531		
D	6.00	6.20	6.10		
D1	5.21	-	-		
е	-	- 2.28			
Е	6.45	6.70	6.58		
E1	4.32	-	-		
Н	9.40	10.41	9.91		
L	1.40	1.78	1.59		
L3	0.88	1.27	1.08		
L4	0.64	1.02	0.83		
а	0°	10°	-		
All Dimensions in mm					

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)
С	4.572
Х	1.060
X1	5.632
Y	2.600
Y1	5.700
Y2	10.700



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